January 2004

## FDB6021P

FAIRCHILD

### 20V P-Channel 1.8V Specified PowerTrench<sup>®</sup> MOSFET

### **General Description**

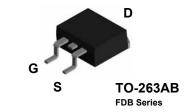
This P-Channel power MOSFET uses Fairchild's low voltage PowerTrench process. It has been optimized for power management applications.

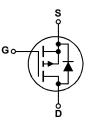
### Applications

- Battery management
- Load switch
- Voltage regulator

### Features

- -28 A, -20 V.  $R_{DS(ON)} = 30 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$  $R_{DS(ON)} = 40 \text{ m}\Omega @ V_{GS} = 2.5 \text{ V}$  $R_{DS(ON)} = 65 \text{ m}\Omega @ V_{GS} = 1.8 \text{ V}$
- Critical DC electrical parameters specified at elevated temperature
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- 175°C maximum junction temperature rating





### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
V <sub>GSS</sub>	Gate-Source Voltage		± 8	V
I <sub>D</sub>	Drain Current – Continuous	(Note 1)	-28	A
	– Pulsed	(Note 1)	-80	
PD	Total Power Dissipation @ T <sub>c</sub> = 25°C		37	W
	Derate above 25°C		0.25	W°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temp	perature Range	-65 to +175	°C
Therma	al Characteristics		4	°C/W
	Thermal Resistance, Junction-to-Case		4	-
R <sub>0JA</sub>	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

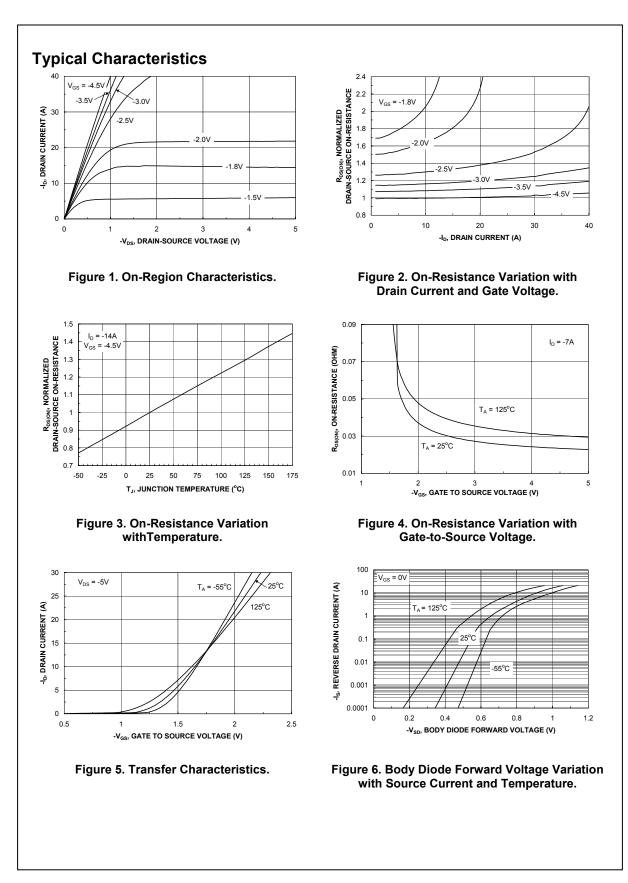
Device Marking	Device	Reel Size	Tape width	Quantity
FDB6021P	FDB6021P	13"	24mm	800 units

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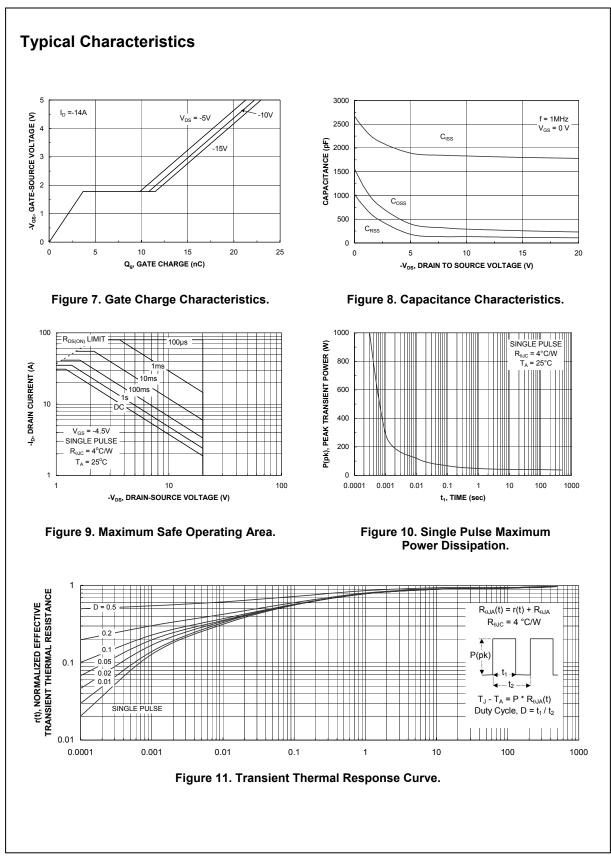
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100 nA 100 nA 1.5 V mV/°C 30 mΩ	-1 100 -100	-16	-20			
mV/°C -1 μA 100 nA 100 nA 1.5 V mV/°C 30 mΩ	100 -100	-16	-20	N/ 0.1/1 050 A	acteristics	Off Char
-1 μA 100 nA 100 nA 1.5 V mV/°C 30 mΩ	100 -100	-16		$V_{GS} = 0 V, I_D = -250 \mu A$	Drain–Source Breakdown Voltage	BV <sub>DSS</sub>
100 nA 100 nA 1.5 V mV/°C 30 mΩ	100 -100			$I_D$ = -250 µA,Referenced to 25°C	Breakdown Voltage Temperature Coefficient	<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>
100 nA 1.5 V mV/°C 30 mΩ	-100			$V_{DS} = -16 V$ , $V_{GS} = 0 V$	Zero Gate Voltage Drain Current	I <sub>DSS</sub>
1.5 V mV/°C 30 mΩ				$V_{GS} = 8 V$ , $V_{DS} = 0 V$	Gate–Body Leakage, Forward	I <sub>GSSF</sub>
mV/°C				$V_{GS} = -8 V$ $V_{DS} = 0 V$	Gate–Body Leakage, Reverse	
mV/°C					acteristics (Note 2)	On Char
30 mΩ	-1.5	-0.7	-0.4	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	Gate Threshold Voltage	V <sub>GS(th)</sub>
		3		$I_D$ = -250 µA,Referenced to 25°C	Gate Threshold Voltage Temperature Coefficient	$\Delta V_{GS(th)} \Delta T_J$
65	30 40 65 42	24 31 50 30			Static Drain–Source On–Resistance	R <sub>DS(on)</sub>
А			-40	$V_{GS} = -4.5 V$ , $V_{DS} = -5 V$	On-State Drain Current	I <sub>D(on)</sub>
S		33		$V_{DS} = -5 V$ , $I_{D} = -14 A$	Forward Transconductance	<b>g</b> fs
					Characteristics	Dvnamic
pF		1890		$V_{DS} = -10 V$ , $V_{GS} = 0 V$ ,	Input Capacitance	C <sub>iss</sub>
pF		302		f = 1.0 MHz	Output Capacitance	Coss
pF		124			Reverse Transfer Capacitance	C <sub>rss</sub>
					g Characteristics (Note 2)	Switchin
23 ns	23	13		$V_{DD} = -10 V$ , $I_D = -1 A$ ,	Turn–On Delay Time	t <sub>d(on)</sub>
20 ns	20	10		$V_{GS} = -4.5 V$ , $R_{GEN} = 6 \Omega$	Turn–On Rise Time	t <sub>r</sub>
28 ns	128	80		1 [	Turn–Off Delay Time	t <sub>d(off)</sub>
80 ns	80	50			Turn–Off Fall Time	t <sub>f</sub>
28 nC	28	20		$V_{DS} = -10 V$ , $I_D = -14 A$ ,	Total Gate Charge	Qg
nC		4		$V_{GS}$ = -4.5 V	Gate-Source Charge	Q <sub>gs</sub>
nC		7			Gate-Drain Charge	Q <sub>gd</sub>
				and Maximum Ratings	ource Diode Characteristics	Drain-So
-28 A	-28				Maximum Continuous Drain-Source	ls
1.3 V	-1.3	-0.9		$V_{GS} = 0 V, I_{S} = -14 A$	Drain–Source Diode Forward Voltage	V <sub>SD</sub>
		4 7 -0.9	urrent limita	And Maximum Ratings	Gate–Source Charge Gate–Drain Charge Durce Diode Characteristics Maximum Continuous Drain–Source Drain–Source Diode Forward Voltage	Q <sub>gs</sub> Q <sub>gd</sub> <b>Drain–Sc</b> I <u>s</u> V <sub>SD</sub> <b>Dtes:</b> Pulse Test: Pu

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FDB6021P Rev. D(W)



# FDB6021P

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